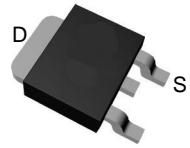


N-Channel Enhancement Mode MOSFET

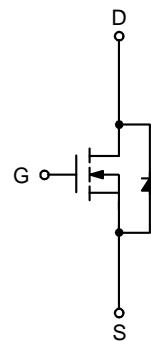
Features

- 40V/60A,
 $R_{DS(ON)}=7.2\text{m}\Omega$ (Typ.) @ $V_{GS}=10\text{V}$
 $R_{DS(ON)}=9.2\text{m}\Omega$ (Typ.) @ $V_{GS}=4.5\text{V}$
- Reliable and Rugged
- Lead Free and Green Devices Available
(RoHS Compliant)

Pin Description



Top View of TO-252-2



N-Channel MOSFET

Applications

- Power Management in Desktop Computer or DC/DC Converters.

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
Common Ratings ($T_A=25^\circ\text{C}$ Unless Otherwise Noted)			
V_{DSS}	Drain-Source Voltage	40	V
$BV_{DS(\text{Avalanche})}^*$	Drain-Source Avalanche Voltage (Maximum)	45	
V_{GSS}	Gate-Source Voltage	± 20	
T_J	Maximum Junction Temperature	175	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 175	$^\circ\text{C}$
I_S	Diode Continuous Forward Current	40	A
I_{DP}	300 μs Pulse Drain Current Tested	$T_c=25^\circ\text{C}$	160
		$T_c=100^\circ\text{C}$	90
I_D	Continuous Drain Current	$T_c=25^\circ\text{C}$	60***
		$T_c=100^\circ\text{C}$	48
P_D	Maximum Power Dissipation	$T_c=25^\circ\text{C}$	60
		$T_c=100^\circ\text{C}$	30
$R_{\theta JC}$	Thermal Resistance-Junction to Case	2.5	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	50	$^\circ\text{C}/\text{W}$
E_{AS}^{**}	Drain-Source Avalanche Energy $L=0.5\text{mH}$	100	mJ

Notes :

* Avalanche single pulse test and avalanche period time $t_{av} \leq 100 \mu\text{s}$, duty < 1% .

** Avalanche test condition: $T_J=25^\circ\text{C}$, $L=0.5\text{mH}$, $I_{AS}=20\text{A}$, $V_{DD}=30\text{V}$, and $V_{GS}=10\text{V}$.

*** Current limited by bond wire.

Electrical Characteristics (Cont.) ($T_A = 25^\circ\text{C}$ unless otherwise noted)

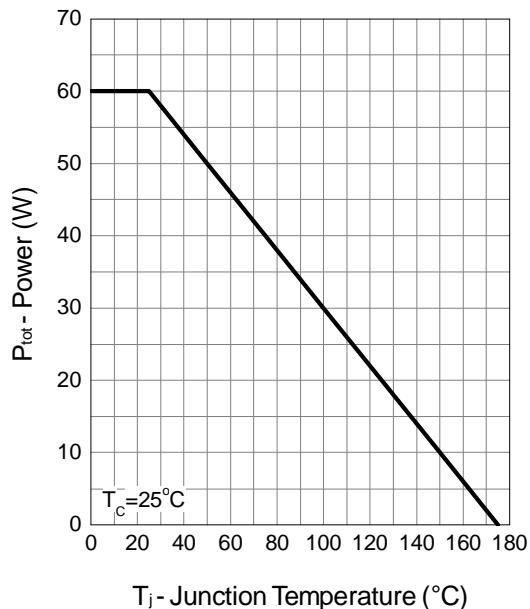
Symbol	Parameter	Test Conditions	XP4184			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=250\mu\text{A}$	40	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=32\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
		$T_J=85^\circ\text{C}$	-	-	30	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{DS}}=250\mu\text{A}$	1.2	1.6	2	V
I_{GSS}	Gate Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
$R_{\text{DS(ON)}}^{\text{a}}$	Drain-Source On-state Resistance	$V_{\text{GS}}=10\text{V}, I_{\text{DS}}=20\text{A}$	-	7.2	9	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{DS}}=10\text{A}$	-	9.2	13	
Diode Characteristics						
V_{SD}^{a}	Diode Forward Voltage	$I_{\text{SD}}=20\text{A}, V_{\text{GS}}=0\text{V}$	-	0.8	1.1	V
t_{rr}	Reverse Recovery Time	$I_{\text{DS}}=40\text{A},$ $dI_{\text{SP}}/dt=100\text{A}/\mu\text{s}$	-	28	-	ns
Q_{rr}	Reverse Recovery Charge		-	24	-	nC
Dynamic Characteristics ^b						
R_{G}	Gate Resistance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, F=1\text{MHz}$	-	1.4	-	Ω
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V},$ $V_{\text{DS}}=20\text{V},$ Frequency=1.0MHz	-	1460	-	pF
C_{oss}	Output Capacitance		-	180	-	
C_{rss}	Reverse Transfer Capacitance		-	146	-	
$t_{\text{d(ON)}}$	Turn-on Delay Time		-	11	21	ns
t_{r}	Turn-on Rise Time	$V_{\text{DD}}=20\text{V}, R_{\text{L}}=20\Omega,$ $I_{\text{DS}}=1\text{A}, V_{\text{GEN}}=10\text{V},$ $R_{\text{G}}=6\Omega$	-	13	24	
$t_{\text{d(OFF)}}$	Turn-off Delay Time		-	37	67	
t_{f}	Turn-off Fall Time		-	11	21	
Gate Charge Characteristics ^b						
Q_{g}	Total Gate Charge	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=10\text{V},$ $I_{\text{DS}}=40\text{A}$	-	31.2	44	nC
Q_{gs}	Gate-Source Charge		-	3.8	-	
Q_{gd}	Gate-Drain Charge		-	9	-	

Note a : Pulse test ; pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

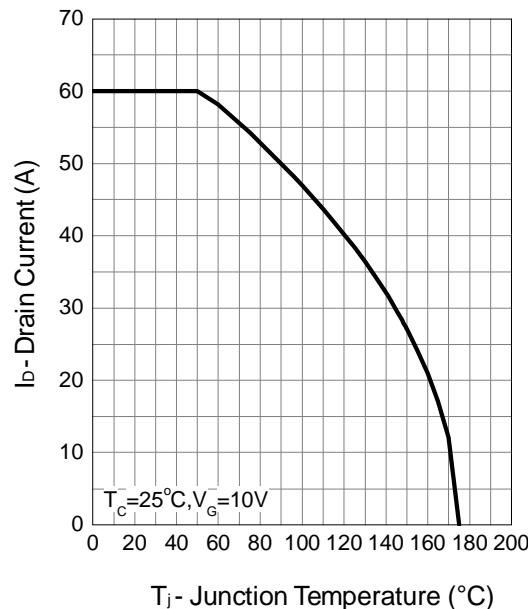
Note b : Guaranteed by design, not subject to production testing.

Typical Operating Characteristics

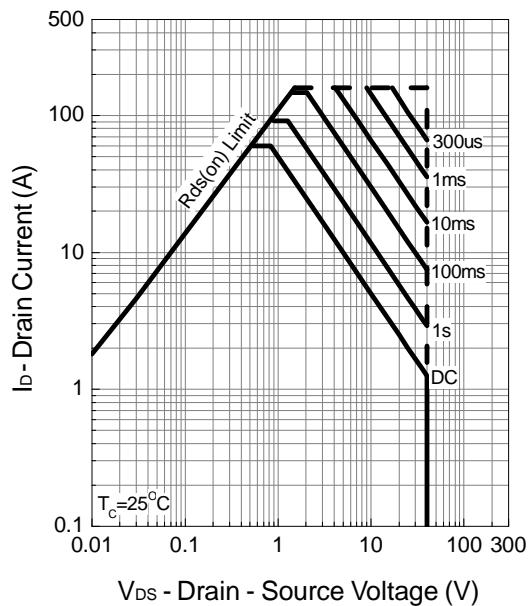
Power Dissipation



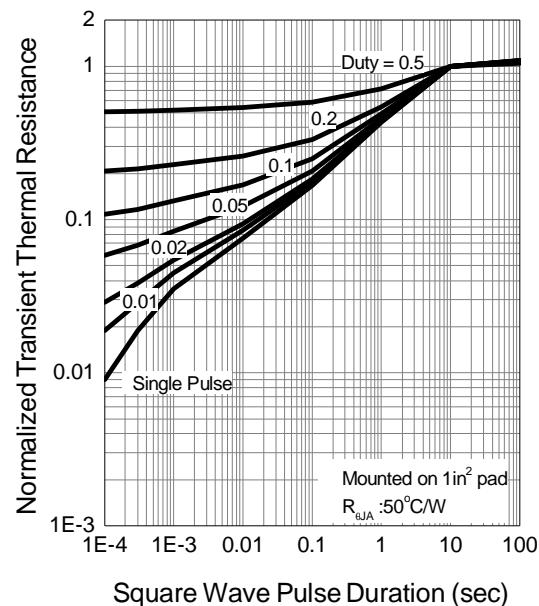
Drain Current



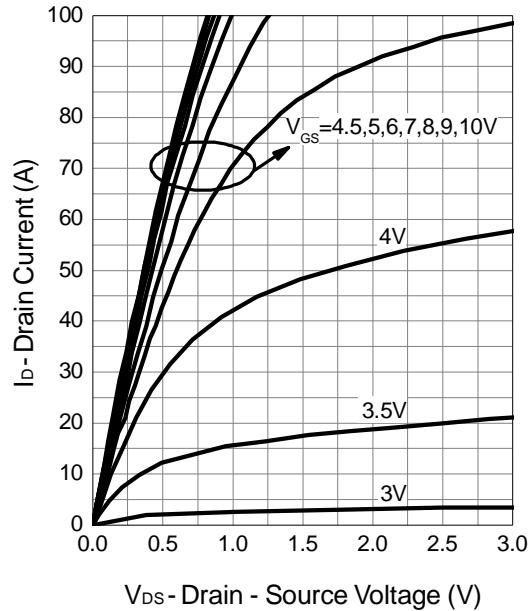
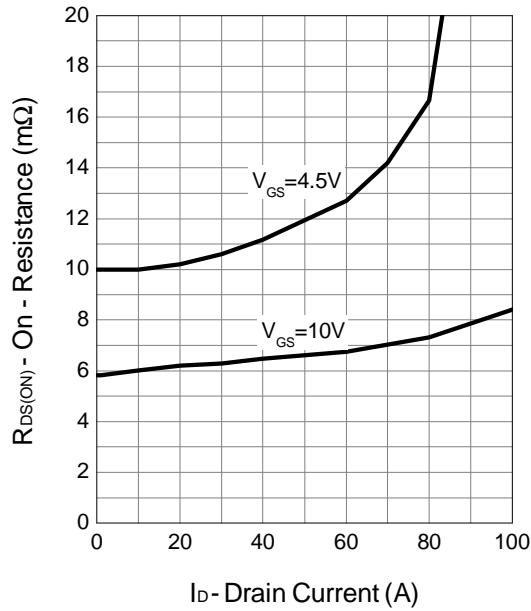
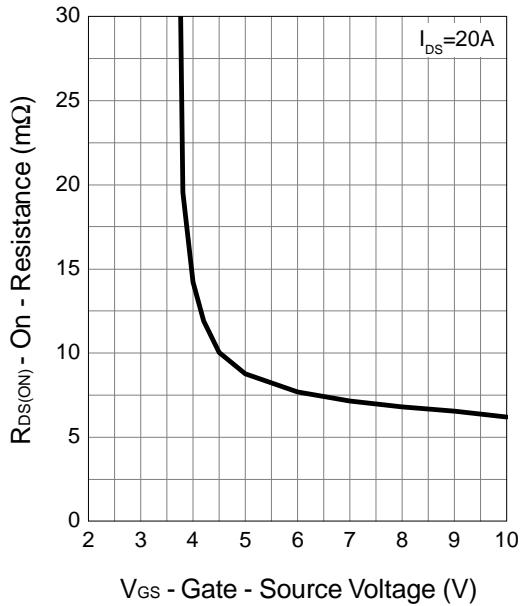
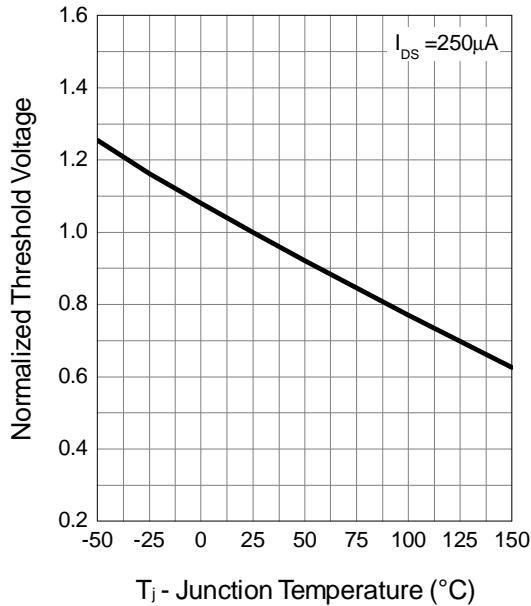
Safe Operation Area



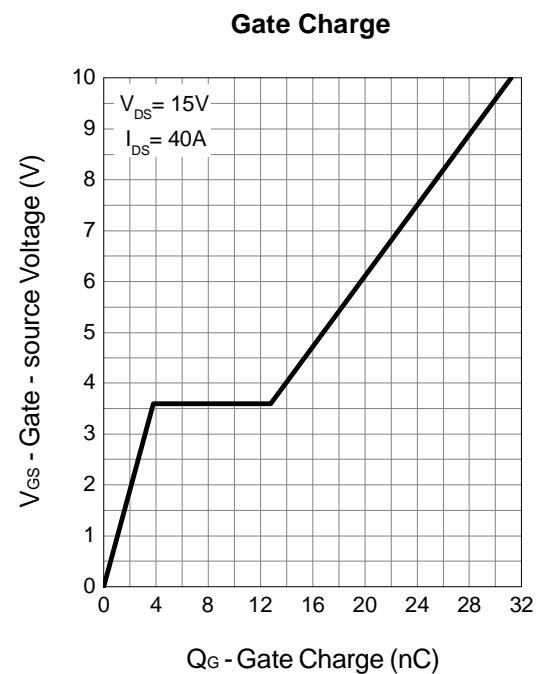
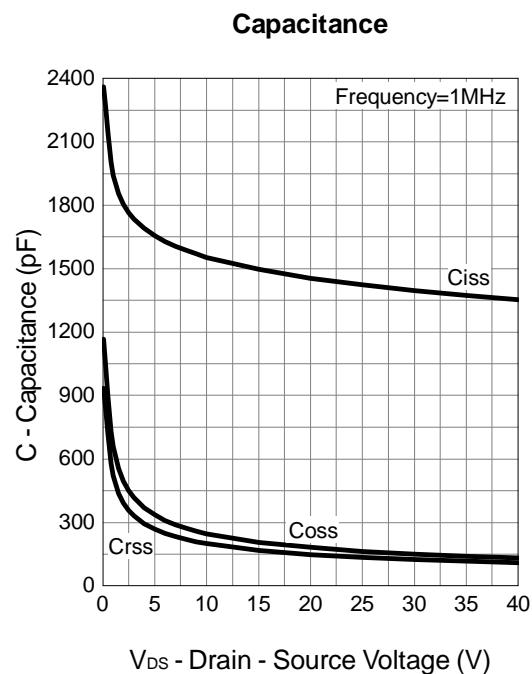
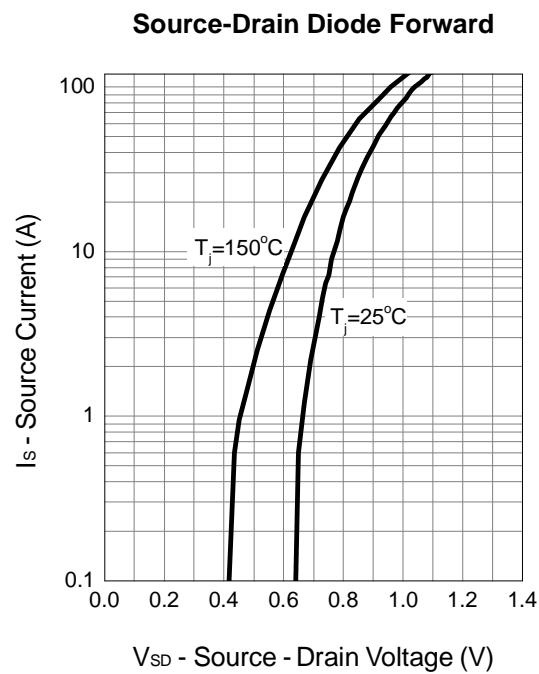
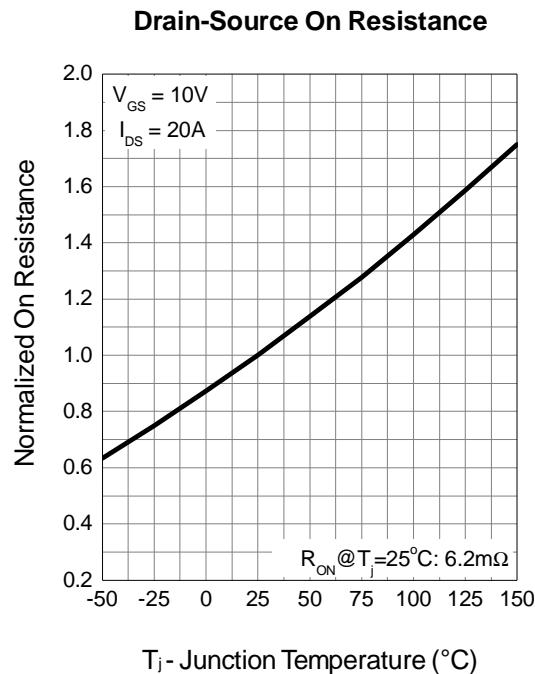
Thermal Transient Impedance



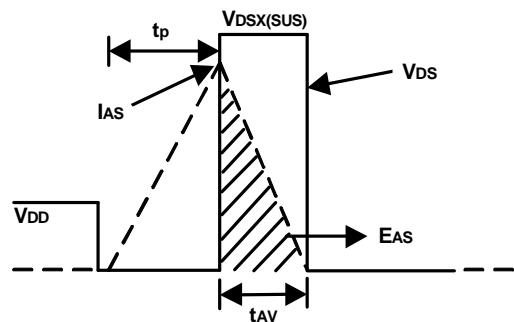
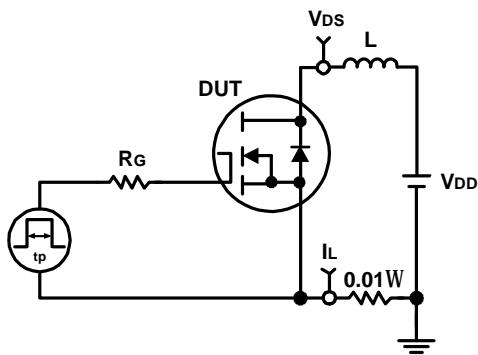
Typical Operating Characteristics (Cont.)

Output Characteristics**Drain-Source On Resistance****Gate-Source On Resistance****Gate Threshold Voltage**

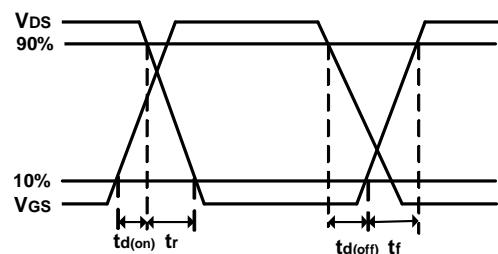
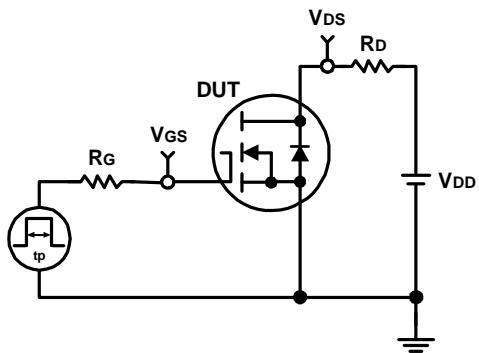
Typical Operating Characteristics (Cont.)



Avalanche Test Circuit and Waveforms

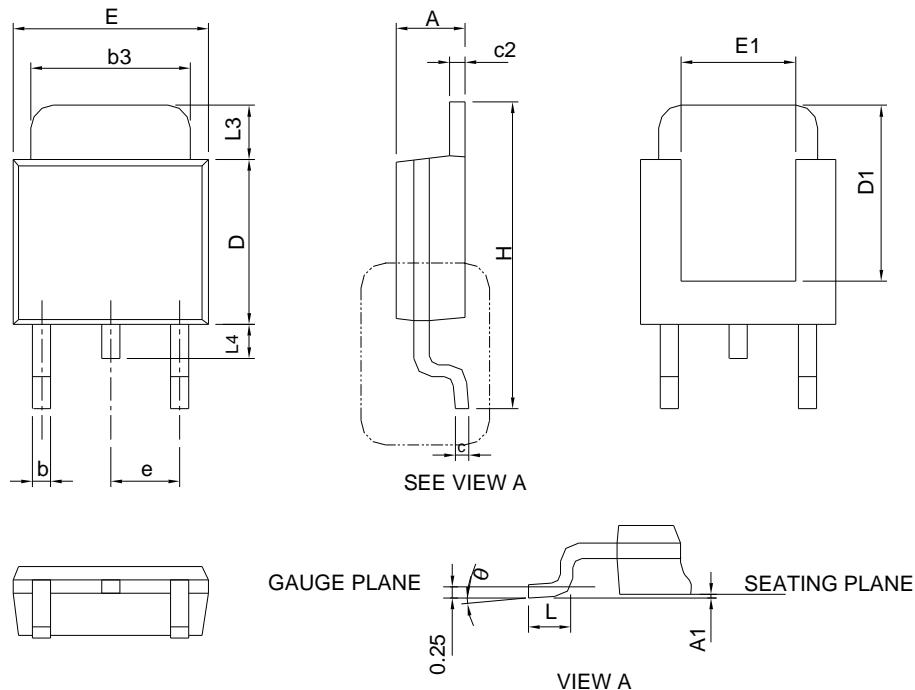


Switching Time Test Circuit and Waveforms



Package Information

TO-252-2



SYMBOL	TO-252-3				RECOMMENDED LAND PATTERN
	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
A	2.18	2.39	0.086	0.094	
A1	-	0.13	-	0.005	
b	0.50	0.89	0.020	0.035	
b3	4.95	5.46	0.195	0.215	
c	0.46	0.61	0.018	0.024	
c2	0.46	0.89	0.018	0.035	
D	5.33	6.22	0.210	0.245	
D1	4.57	6.00	0.180	0.236	
E	6.35	6.73	0.250	0.265	
E1	3.81	6.00	0.150	0.236	
e	2.29 BSC		0.090 BSC		
H	9.40	10.41	0.370	0.410	
L	0.90	1.78	0.035	0.070	
L3	0.89	2.03	0.035	0.080	
L4	-	1.02	-	0.040	
θ	0°	8°	0°	8°	

Note : Follow JEDEC TO-252 .

RECOMMENDED LAND PATTERN

